

Notice of References Cited	Application/Control No. 10/653,199	Applicant(s)/Patent Under Reexamination FUJII, YUKIO	
	Examiner Aaron M. Dunwoody	Art Unit 3679	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,740,175	05-2004	Kitano, Shuhei	148/328
	B	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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